June 1988 Revised January 2004

## 74F219 64-Bit Random Access Memory with 3-STATE Outputs

#### **General Description**

FAIRCHILD

SEMICONDUCTOR

The 74F219 is a high-speed 64-bit RAM organized as a 16-word by 4-bit array. Address inputs are buffered to minimize loading and are fully decoded on-chip. The outputs are 3-STATE and are in the high-impedance state whenever the Chip Select ( $\overline{\text{CS}}$ ) input is HIGH. The outputs are active only in the Read mode. This device is similar to the 74F189 but features non-inverting, rather than inverting, data outputs.

#### Features

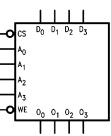
- 3-STATE outputs for data bus applications
- Buffered inputs minimize loading
- Address decoding on-chip
- Diode clamped inputs minimize ringing
- Available in SOIC (300 mil only)

**Connection Diagram** 

#### **Ordering Code:**

Order Number	Package Number	Package Description
74F219SC	M16B	16-Lead Small Outline Intergrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74F219PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

#### Logic Symbol



## $A_0 = 1 \qquad 16$ $\overline{CS} = 2 \qquad 15$

WE -	3	14	- A <sub>2</sub>
D <sub>0</sub> —	4	13	- A3
0 <sub>0</sub> —	5	12	— D <sub>3</sub>
D <sub>1</sub> -	6	11	-0 <sub>3</sub>
01-	7	10	- D <sub>2</sub>
GND -	8	9	-0 <sub>2</sub>
			-

Vcc

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# 74F219

#### Unit Loading/Fan Out

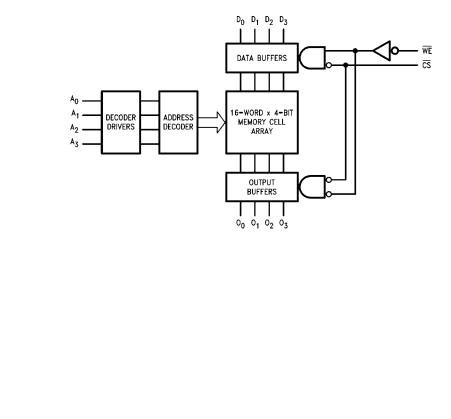
Din Namas	Description	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>		
Pin Names	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>		
A <sub>0</sub> -A <sub>3</sub>	Address Inputs	1.0/1.0	20 µA/–0.6 mA		
CS	Chip Select Input (Active LOW)	1.0/2.0	20 μA/–1.2 mA		
WE	Write Enable Input (Active LOW)	1.0/1.0	20 µA/–0.6 mA		
D <sub>0</sub> –D <sub>3</sub>	Data Inputs	1.0/1.0	20 μA/–0.6 mA		
O <sub>0</sub> -O <sub>3</sub>	3-STATE Data Outputs	150/40 (33.3)	–3 mA/24 mA (20 mA)		

#### **Function Table**

Inputs		Operation	Condition of Outputs			
CS	WE	· · ·				
L	L	Write	High Impedance			
L	н	Read	True Stored Data			
н х		Inhibit	High Impedance			

H = HIGH Voltage Level L = LOW Voltage Level X = Immaterial

#### **Block Diagram**



#### Absolute Maximum Ratings(Note 1)

Storage Temperature Ambient Temperature under Bias Junction Temperature under Bias V<sub>CC</sub> Pin Potential to Ground Pin Input Voltage (Note 2) Input Current (Note 2) Voltage Applied to Output in HIGH State (with V<sub>CC</sub> = 0V) Standard Output 3-STATE Output Current Applied to Output in LOW State (Max) -65°C to +150°C -55°C to +125°C -55°C to +150°C -0.5V to +7.0V -0.5V to +7.0V -30 mA to +5.0 mA

-0.5V to V<sub>CC</sub>

-0.5V to +5.5V

twice the rated  $I_{OL}\left(mA\right)$ 

## Recommended Operating Conditions

Free Air Ambient Temperature Supply Voltage

74F219

0°C to +70°C +4.5V to +5.5V

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Symbol	Parameter		Min	Тур	Max	Units	V <sub>cc</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
VIL	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5					I <sub>OH</sub> = -1 mA
	Voltage	10% V <sub>CC</sub>	2.4			v	Min	$I_{OH} = -3 \text{ mA}$
		5% V <sub>CC</sub>	2.7			v	IVIII	$I_{OH} = -1 \text{ mA}$
		5% V <sub>CC</sub>	2.7					I <sub>OH</sub> = -3 mA
V <sub>OL</sub>	Output LOW	10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 24 mA
	Voltage							
I <sub>IH</sub>	Input HIGH				5.0		Max	V <sub>IN</sub> = 2.7V
	Current				5.0	μA	wax	$v_{IN} = 2.7 v$
I <sub>BVI</sub>	Input HIGH Current				7.0		Max	V <sub>IN</sub> = 7.0V
	Breakdown Test				7.0	μA	wax	$v_{IN} = 7.0v$
ICEX	Output HIGH				50	μA	Max	
	Leakage Current				50	μΑ	IVIAX	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage		4.75			v	0.0	I <sub>ID</sub> = 1.9 μA
	Test		4.75			v	0.0	All Other Pins Grounded
I <sub>OD</sub>	Output Leakage				3.75		0.0	V <sub>IOD</sub> = 150 mV
	Circuit Current				3.75	μA	0.0	All Other Pins Grounded
Ι <sub>ΙL</sub>	Input LOW				-0.6			$V_{IN} = 0.5V (A_n, \overline{WE}, D_n)$
	Current				-1.2	mA	Max	$V_{IN} = 0.5V (\overline{CS})$
I <sub>OZH</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V
I <sub>OZL</sub>	Output Leakage Current				-50	μΑ	Max	V <sub>OUT</sub> = 0.5V
I <sub>OS</sub>	Output Short-Circuit Current		-60		-150	mA	Max	V <sub>OUT</sub> = 0V
I <sub>ZZ</sub>	Bus Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V
I <sub>CC</sub>	Power Supply Current			37	55	mA	Max	

#### **DC Electrical Characteristics**

74F219

#### **AC Electrical Characteristics**

Symbol		$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$\label{eq:T_A} \begin{split} T_A = -55^\circ C \ to + 125^\circ C \\ V_{CC} = +5.0V \\ C_L = 50 \ pF \end{split}$		$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units
	Parameter								
	Parameter								
		Min	Тур	Max	Min	Max	Min	Max	
t <sub>PLH</sub>	Access Time, HIGH or LOW	10.0	18.5	26.0	9.0	32.0	10.0	27.0	ns
t <sub>PHL</sub>	A <sub>n</sub> to O <sub>n</sub>	8.0	13.5	19.0	8.0	23.0	8.0	20.0	115
t <sub>PZH</sub>	Access Time, HIGH or LOW	3.5	6.0	8.5	3.5	10.5	3.5	9.5	
t <sub>PZL</sub>	CS to On	5.0	9.0	13.0	5.0	15.0	5.0	14.0	ns
t <sub>PHZ</sub>	Disable Time, HIGH or LOW	2.0	4.0	6.0	2.0	8.0	2.0	7.0	115
t <sub>PLZ</sub>	CS to O <sub>n</sub>	3.0	5.5	8.0	2.5	10.0	3.0	9.0	
t <sub>PZH</sub>	Write Recovery Time	6.5	20.0	28.0	6.5	37.5	6.5	29.0	
t <sub>PZL</sub>	HIGH or LOW, WE to On	6.5	11.0	15.5	6.5	17.5	6.5	16.5	ns
t <sub>PHZ</sub>	Disable Time, HIGH or LOW	4.0	7.0	10.0	3.5	12.0	4.0	11.0	115
t <sub>PLZ</sub>	WE to On	5.0	9.0	13.0	5.0	15.0	5.0	14.0	

### AC Operating Requirements

Symbol	Parameter		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0^\circ C \text{ to } +70^\circ C$ $V_{CC} = +5.0 V$		
		Min	Max	Min	Max	Min	Max		
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	0		0		0			
t <sub>S</sub> (L)	A <sub>n</sub> to WE	0 0 0							
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	2.0		2.0		2.0		ns	
t <sub>H</sub> (L)	A <sub>n</sub> to WE	2.0		2.0		2.0			
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	10.0		11.0		10.0			
t <sub>S</sub> (L)	D <sub>n</sub> to WE	10.0		11.0		10.0		ns	
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	0		2.0		0		115	
t <sub>H</sub> (L)	D <sub>n</sub> to WE	0		2.0		0			
t <sub>S</sub> (L)	Setup Time, LOW	0		0		0		ns	
t <sub>H</sub> (L)	Hold Time, LOW CS to WE	6.0		7.5		6.0		115	
t <sub>W</sub> (L)	WE Pulse Width, LOW	6.0		15.0		6.0		ns	

